Product Preview

MOSFET - Power, N-Channel, Logic Level 50 V, 16 A, 47 m Ω

These are N-Channel logic level power MOSFETs manufactured using the MegaFET process. This process, which uses feature sizes approaching those of LSI integrated circuits gives optimum utilization of silicon, resulting in outstanding performance. They were designed for use with logic level (5 V) driving sources in applications such as programmable controllers, switching regulators, switching converters, motor relay drivers and emitter switches for bipolar transistors. This performance is accomplished through a special gate oxide design which provides full rated conductance at gate biases in the 3 V to 5 V range, thereby facilitating true on-off power control directly from logic circuit supply voltages.

Formerly developmental type TA09871.

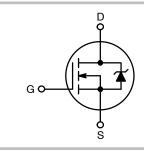
Features

- 16 A, 50 V
- $r_{DS(ON)} = 0.047 \Omega$
- UIS SOA Rating Curve (Single Pulse)
- Design Optimized for 5 V Gate Drives
- Can be Driven Directly from CMOS, NMOS, TTL Circuits
- SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- Linear Transfer Characteristics
- High Input Impedance
- Majority Carrier Device
- Related Literature
 - ◆ TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"



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DPAK TO-252 CASE 369AS

MARKING DIAGRAM



&Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code

&K = Lot Code

RFD16N05LSM = Specific Device Code

ORDERING INFORMATION

Part Number	Package	Brand
RFD16N05LSM9A	TO-252AA	RFD16N05LSM

MAXIMUM RATINGS

Rating	Symbol	RFD16N05LSM9A	Units
Drain to Source Voltage (Note 1)	V _{DS}	50	V
Drain to Gate Voltage (R _{GS} 20 kΩ) (Note 1)	V_{DGR}	50	V
Continuous Drain Current	I _D	16	Α
Pulsed Drain Current (Note 3)	I _{DM}	45	Α
Gate to Source Voltage	V_{GS}	±10	V
Maximum Power Dissipation	P _D	60	W
Derate Above 25°C		0.48	W/°C
Operating and Storage Temperature	T _J , T _{STG}	-55 to 150	°C
Maximum Temperature for Soldering			
Leads at 0.063 in (1.6 mm) from Case for 10 s	T _L	300	°C
Package Body for 10 s, See Techbrief 334	T _{pkg}	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. $T_J = 25^{\circ}C$ to $125^{\circ}C$.

ELECTRICAL SPECIFICATIONS (T_C = 25°C unless otherwise specified)

PARAMETER	SYMBOL	TEST CON	DITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 250 mA, V _{GS} = 0 V, Figure 10		50	-	-	V
Gate to Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250 \mu A$, Figure 9		1	-	2	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V		-	-	1	μΑ
			$T_C = 150^{\circ}C$	-	-	50	μА
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 10 \text{ V}, V_{DS} = 0$	V	-	-	100	nA
Drain to Source On Resistance (Note 2)	r _{DS(ON)}	I _D = 16 A, V _{GS} = 5 V I _D = 16 A, V _{GS} = 4 V		-	-	0.047	Ω
				-	-	0.056	Ω
Turn-On Time	t _(ON)	V_{DD} = 25 V, I_{D} = 8 A, V_{GS} = 5 V, R_{GS} = 12.5 Ω Figures 15, 16		-	-	60	ns
Turn-On Delay Time	t _{d(ON)}			-	14	_	ns
Rise Time	t _r			-	30	-	ns
Turn-Off Delay Time	t _{d(OFF)}			-	42	-	ns
Fall Time	t _f				14	-	ns
Turn-Off Time	t _(OFF)				-	-	ns
Total Gate Charge	Q _{g(TOT)}	V _{GS} = 0 V to 10 V	V _{DD} = 40 V,	-	-	80	nC
Gate Charge at 5 V	Q _{g(5)}	V _{GS} = 0 V to 5 V	I_D = 16 A, R_L = 2.5 Ω Figures 17, 18	-	-	45	nC
Threshold Gate Charge	Q _{g(TH)}	V _{GS} = 0 V to 1 V		-	-	3	nC
Thermal Resistance Junction to Case	$R_{ heta JC}$			-	-	2.083	°C/W
Thermal Resistance Junction to Ambient	$R_{ heta JA}$			-	-	100	°C/W

SOURCE TO DRAIN DIODE SPECIFICATIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Source to Drain Diode Voltage	V_{SD}	I _{SD} = 16 A	-	-	1.5	V
Diode Reverse Recovery Time	t _{rr}	$I_{SD} = 16 \text{ A}, dI_{SD}/dt = 100 \text{ A}/\mu\text{s}$	-	-	125	ns

Pulse Test: Pulse Width ≤300 ms, Duty Cycle ≤2%.
 Repetitive Rating: Pulse Width limited by max junction temperature.

TYPICAL PERFORMANCE CURVES (Unless Otherwise Specified)

DRAIN CURRENT (A)

ۻ 5

20

15

10

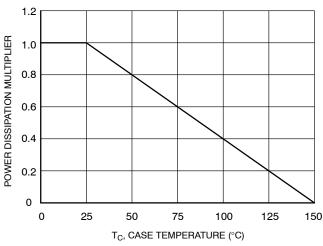


Figure 1. Normalized Power Dissipation vs

Case Temperature

0 150 25 50 75 T_C, CASE TEMPERATURE (°C)

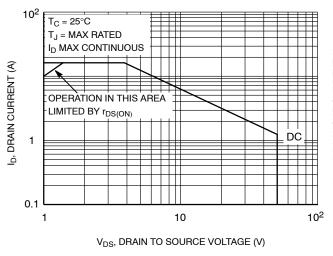


Figure 3. Forward Bias Safe Operating Area

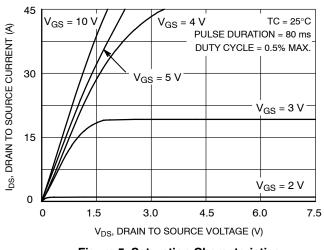
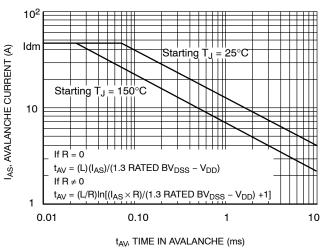


Figure 5. Saturation Characteristics



100

Figure 2. Maximum Continuous Drain Current

vs Case Temperature

125

150

Figure 4. Unclamped Inductive Switching SOA (Single Pulse UIS SOA)

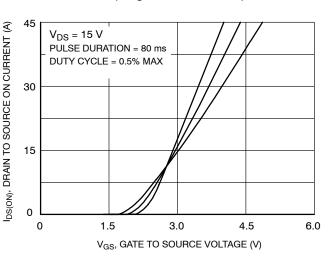


Figure 6. Transfer Characteristics

TYPICAL PERFORMANCE CURVES (Unless Otherwise Specified) (continued)

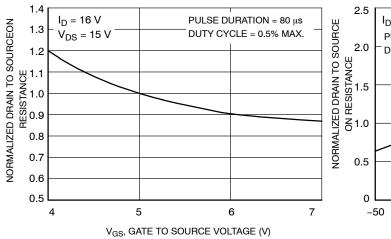


Figure 7. Drain to Source on Resitance vs Gate Voltageand Drain Current

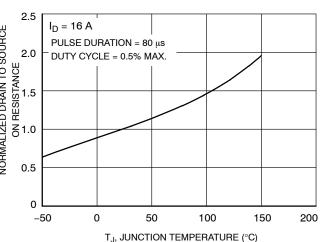


Figure 8. Normalized Drain to Source on Resistance vs. Junction Temperature

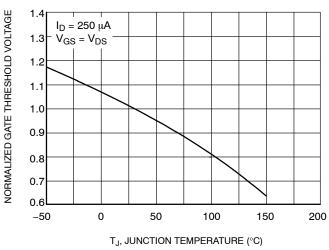


Figure 9. Normalized Gate Threshold vs Junction Temperature

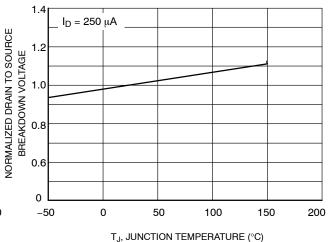


Figure 10. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

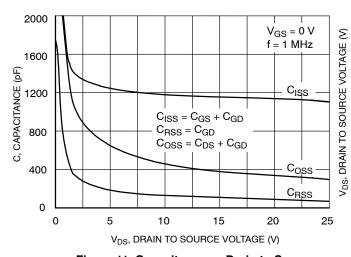


Figure 11. Capacitance vs Drain to Source Voltage

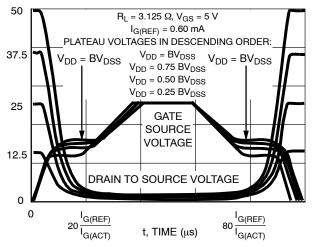


Figure 12. Normalized Switching Waveforms for Constant Gate Current

TEST CIRCUITS AND WAVEFORMS

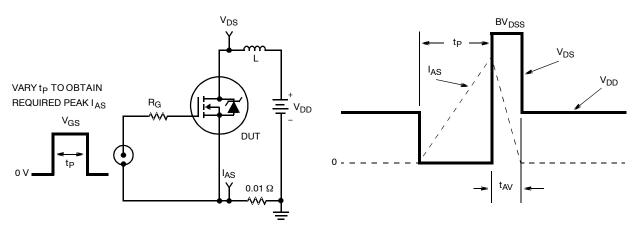


Figure 13. Unclamped Energy Test Circuit

Figure 14. Unclamped Energy Waveforms

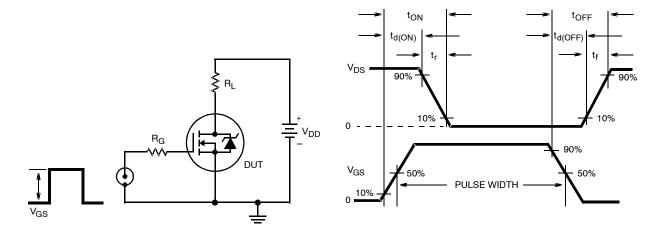


Figure 15. Switching Time Test Circuit

Figure 16. Resistive Switching Waveforms

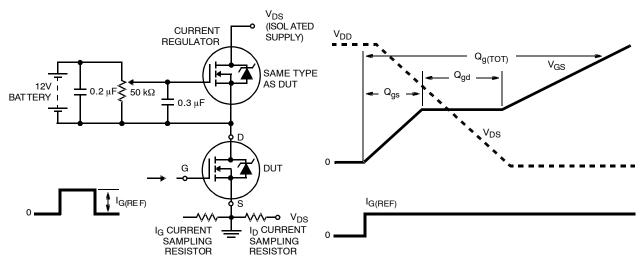


Figure 17. Gate Charge Test Circuit

Figure 18. Gate Charge Waveforms

PSPICE ELECTRICAL MODEL

```
.SUBCKT RFD16N05L 2 1 3 ; REV 4/8/92
Ca 12 8 3.33e-9
Cb 15 14 3.11e-9
Cin 6 8 1.21e-9
Dbody 7 5 DBDMOD
Dbreak 5 11 DBKMOD
Dplcap 10 5 DPLCAPMOD
Ebreak 11 7 17 18 70.9
Eds 14 8 5 8 1
Egs 13 8 6 8 1
Esg 6 10 6 8 1
Evto 20 6 18 8 1
IT 8 17 1
Lgate 1 9 1.38e-9
Ldrain 2 5 1.0e-12
Lsource 3 7 1.0e-9
Mos1 16 6 8 8 MOSMOD M = 0.99
Mos2\ 16\ 21\ 8\ 8\ MOSMOD\ M\ =\ 0.01
Rin 6 8 1e9
Rbreak 17 18 RBKMOD 1
Rdrain 5 16 RDSMOD 27.38e-3
Rgate 9 20 2.98
Rsource 8 7 RDSMOD 0.614e-3
Rvto 18 19 RVTOMOD 1
S1a 6 12 13 8 S1AMOD
S1b 13 12 13 8 S1BMOD
S2a 6 15 14 13 S2AMOD
S2b 13 15 14 13 S2BMOD
Vbat 8 19 DC 1
Vto 21 6 0.448
.MODEL DBDMOD D (IS = 1.34e-13 RS = 1.21e-2 TRS1 = 1.64e-3 TRS2 = 2.59e-6 +CJO = 1.13e-9
TT = 4.14e-8)
.MODEL DBKMOD D (RS = 8.82e-2 TRS1 = -2.01e-3 TRS2 = 7.32e-10)
.MODEL DPLCAPMOD D (CJO = 0.522e-9 IS = 1e-30 N = 10)
.MODEL MOSMOD NMOS (VTO = 2.054 KP = 24.73 IS = 1e-30 N = 10 TOX = 1 L = 1u W = 1u)
.MODEL RBKMOD RES (TC1 = 1.01e-3 TC2 = 5.21e-8)
.MODEL RDSMOD RES (TC1 = 3.66e-3 TC2 = 1.46e-5)
.MODEL RVTOMOD RES (TC1 = -1.81e-3 TC2 = 1.41e-6)
.MODEL S1AMOD VSWITCH(RON = 1e-5 ROFF = 0.1 VON = -4.25 VOFF = -2.25)
.MODEL S1BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -2.25 VOFF = -4.25)
.MODEL S2AMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = -0.65 VOFF = 4.35)
.MODEL S2BMOD VSWITCH (RON = 1e-5 ROFF = 0.1 VON = 4.35 VOFF = -0.65)
.ENDS
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NOTE: For further discussion of the PSPICE model, consult A New PSPICE Sub-Circuit for the Power MOSFET Featuring Global Temperature Options; written by William J. Hepp and C. Frank Wheatley.

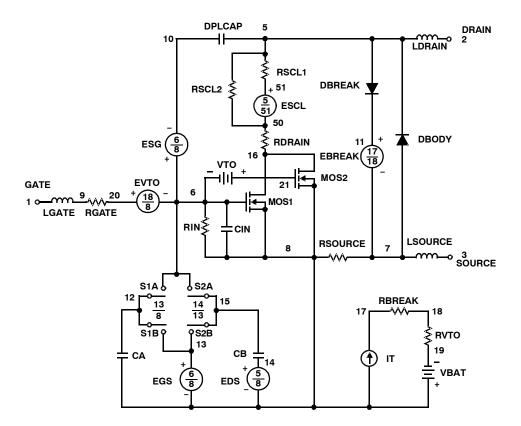


Figure 19.

CASE 369AS **ISSUE O DATE 30 SEP 2016** 6.73 6.35 5,46 5.55 MIN-6.50 MIN 6.40 0.25 MAX Ċ PLASTIC BODY STUB MIN DIODE PRODUCTS VERSION (0.59)-1.25 MIN 0.89 ⊕ 0.25 M AM C 2.29 2.28 4.56 4.57 LAND PATTERN RECOMMENDATION NON-DIODE PRODUCTS VERSION В 2.39 SEE 2.18 4.32 MIN NOTE D 0.58 0.45 5.21 MIN 10.41 9.40 SEE DETAIL A

DPAK3 (TO-252 3 LD)

NOTES: UNLESS OTHERWISE SPECIFIED

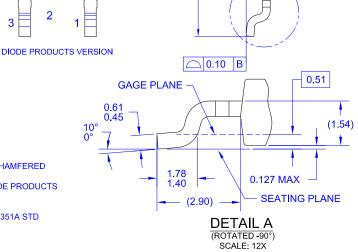
2

A) THIS PACKAGE CONFORMS TO JEDEC, TO-252,

NON-DIODE PRODUCTS VERSION

3

- ISSUE C, VARIATION AA.
 B) ALL DIMENSIONS ARE IN MILLIMETERS.
 C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
- E TRIMMED CENTER LEAD IS PRESENT ONLY FOR DIODE PRODUCTS
- F) DIMENSIONS ARE EXCLUSSIVE OF BURSS, MOLD FLASH AND TIE BAR EXTRUSIONS.
- G) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.



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